

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:	Mehrdad Nikoonahad et al.		
Title:	Optical System for Measuring Samples Using Short Wavelength Radiation		
Application No.:	10/718,126	Filing Date:	November 19, 2003
Examiner:	Hoa Q. Pham	Group Art Unit:	2877
Docket No.:	TNCR.197US1	Conf. No.:	9108

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

RESPONSE TO OFFICE ACTION AND AMENDMENT

Sir:

This is in response to the Office Action dated August 30, 2006, setting a period for response expiring on November 30, 2006. A petition for an extension of time with accompanying fee is being filed herewith to extend the response period to January 3, 2007, as December 30, 2006 was a Saturday and Monday, January 2, 2007 and Tuesday, January 3, 2007 were National Holidays.

Amendments to the Specification are not being made.

The Claims begin on page 2 of this paper.

Amendments to the Drawings begin on page 20 of this paper. Replacement Drawings follow page 28 of this paper.

Remarks begin on page 21 of this paper.

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